Docket No.

219507US2SDIV

IN THE UNITED STATES RATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

Hideo ANDO, et al.

SERIAL NO:

10/076,284

GAU:

2615

FILED:

February 19, 2002

EXAMINER: Not Assigned

FOR:

INFORMATION STORAGE SYSTEM CAPABLE OF RECORDING AND PLAYING BACK A PLURALITY OF

STILL PICTURES

# INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

ASSISTANT COMMISSIONER FOR PATENTS WASHINGTON, D.C. 20231

SIR:

Applicant(s) wish to disclose the following information.

#### REFERENCES

- The applicant(s) wish to make of record the 10 references listed on the attached form PTO-1449, cited in the 5 attached Explanations of Circumstances Concerning Accelerated Examination for: Japanese Patent No.'s 2001-310033 (filed in the Japanese Patent Office July 1, 2002) 2001-310034 (filed in the JPO June 25, 2002), 2001-310035 (filed in the JPO July 15, 2002), 2001-310036 (filed in the JPO July 15, 2002). Copies of the cited references (with English translations) are attached, as are English translations for said Explanations.
- A check is attached in the amount required under 37 CFR §1.17(p).

### RELATED CASES

- Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
- A check is attached in the amount required under 37 CFR §1.17(p).

#### **CERTIFICATION**

- ☐ Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

## **DEPOSIT ACCOUNT**

Please charge any additional fees for the papers being filed herewith and for which no check is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

James J. Kulbaski

Registration No. 34,648

Thomas J. Fisher

Registration No. 44,681

COPY

22850
Tel. (703) 413-3000

Fax. (703) 413-3000 Fax. (703) 413-2220 (OSMMN 03/02) I:\atty\Chy\219507us\219507 IDS

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			219507US2SDIV	10/076,284				
LIST OF REFERENCES CIPED BY APPLICANT				APPLICANT				
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U.S. PATENT DOCUMENTS								
EXAMINER		DOCUMENTRADER	DATE	NAME	CLASS	SUB	FILING DATE	
INITIAL		NUMBER	DATE		CLASS	CLASS	IF APPROPRIATE	
	AA	5,712,947	27Jan98	Oguro, et al.				
	AB	6,385,389 B1	07May02	Maruyama, et al.				
	AC							
	AD							
	AE							
-	AF							
FOREIGN PATENT DOCUMENTS								
		DOCUMENT DATE COUNTRY TRANSLATION						
		NUMBER	DATE	TE COUNTRY		YES NO		
	AG	EP 1 065 665 A1	03Jan01	European Patent Office (in English)	120	, NO		
	AH	JP 5-165935	2Jul93	JAPAN		×		
	Al	JP 5-81787	02Apr93	JAPAN		×		
	AJ	JP 7-143429	02Jun95	JAPAN		x		
	AK	JP 8-106721	23Apr96	JAPAN		x		
	AL	JP 9-259539	03Oct97	JAPAN	×			
				JAPAN (corresponding U.S. Patent no.	^			
	AM	JP 11-215471	6Aug99	6,385,389 B1 Maruyama, et al.)  JAPAN (corresponding European Pater	t No. ED		×	
	AN	JP 11-238362	31Aug99	1 065 665, <u>ANDO, et al.</u> )		×		
	AO							
	AP							
	AQ							
	AR							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AS	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310033 (with English translation)						
		Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310034 (with						
	AT	English translation)						
		Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310035 (with						
	AU	English translation)						
		Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310036 (with						
	AV	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310036 (with English translation)						
	AW	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 2001-310037 (with						
-		English translation)						
	AX	Addit				tional References sheet(s) attached		
Examiner					Date Con	Pate Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in								
conformance and not considered. Include copy of this form with next communication to applicant.								

